

Notice of References Cited

Application/Control No.

09/922,488

Applicant(s)/Patent Under
Reexamination
THAYER ET AL.

Examiner

Patrick J. Nolan

Art Unit

1644

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0033504 A1	02-2004	Agarwal et al.	435/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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